

DGG OR DL PACKAGE (TOP VIEW)

SCES080E-JULY 1996-REVISED OCTOBER 2004

•	Member of the Texas Instruments Widebus™
	Family

- UBT<sup>™</sup> Transceiver Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, Clocked, or Clock-Enable Mode
- Operates From 1.65 V to 3.6 V
- Max t<sub>nd</sub> of 3.2 ns at 3.3 V
- ±24-mA Output Drive at 3.3 V
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)

#### **DESCRIPTION/ORDERING INFORMATION**

This 18-bit universal bus transceiver is designed for 1.65-V to 3.6-V  $V_{\rm CC}$  operation.

Data flow in each direction is controlled by output-enable (OEAB and OEBA) and clock-enable (CLKENBA) inputs. For the A-to-B data flow, the data flows through a single buffer. The B-to-A data can flow through a four-stage pipeline register path, or through a single register path, depending on the state of the select (SEL) input.

Data is stored in the internal registers on the low-to-high transition of the clock (CLK) input, provided that the appropriate CLKENBA input is low. The B-to-A data transfer is synchronized with CLK.

(	,	
1	56	] GND
2	55	] SEL
3	54	B1
4	53	] GND
5	52	B2
6	51	<b>]</b> B3
7	50	] V <sub>CC</sub>
8	49	] B4
9	48	B5
10	47	B6
11	46	] GND
12	45	] B7
13	44	B8
14	43	] B9
15	42	B10
16	41	B11
17	40	B12
18	39	] GND
19		] B13
20	37	B14
21	36	B15
22	35	] V <sub>CC</sub>
23		] B16
24	33	B17
25	32	] GND
26	31	B18
27		] CLK
28	29	] GND
	2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27	2    55      3    54      4    53      5    52      6    51      7    50      8    49      9    48      10    47      11    46      12    45      13    44      14    43      15    42      16    41      17    40      18    39      19    38      20    37      21    36      22    35      23    34      24    33      25    32      26    31      27    30

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

ORDERING INFORMATION	ORDERING	INFOR	MATION
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T <sub>A</sub>	PACKAGE <sup>(1)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING		
	SSOP - DL		SN74ALVCH16524DL	ALVCH16524		
-40 to 85°C	550P - DL	Tape and reel	SN74ALVCH16524DLR	ALVCH10524		
	TSSOP - DGG	Tape and reel	SN74ALVCH16524DGGR	ALVCH16524		

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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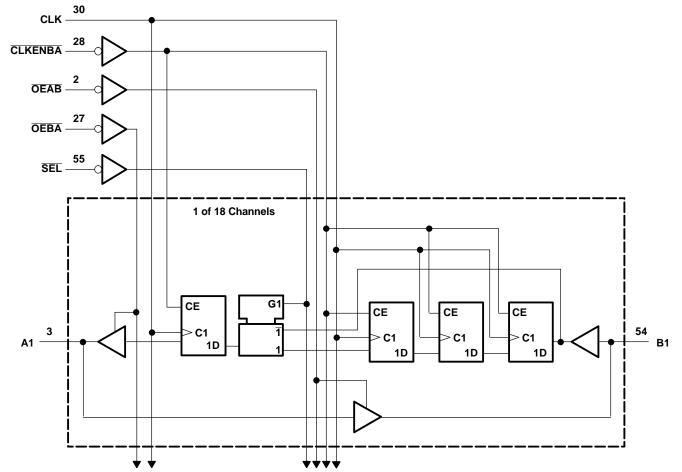
	OUTPUT								
CLKENBA	CLK	SEL	В	Α					
Н	Х	Х	Х	A <sub>0</sub> <sup>(1)</sup>					
L	$\uparrow$	Н	L	L					
L	$\uparrow$	Н	н	н					
L	$\uparrow$	L	L	L <sup>(2)</sup>					
L	$\uparrow$	L	н	H <sup>(2)</sup>					

#### FUNCTION TA<u>BLE</u> B-TO-A STORAGE (OEBA = L)

(1) Output level before the indicated steady-state input conditions were established

(2) Four positive CLK edges are needed to propagate data from B to A when SEL is low.

# LOGIC DIAGRAM (POSITIVE LOGIC)





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### **ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>**

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	4.6	V
VI		Except I/O ports <sup>(2)</sup>	-0.5	4.6	V
	Input voltage range	I/O ports (2)(3)	-0.5	V <sub>CC</sub> + 0.5	v
Vo	Output voltage range <sup>(2)(3)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	
I <sub>O</sub>	Continuous output current			±50	mA
	Continuous current through each $V_{CC}$ or GND			±100	mA
0	Declarse thermal importance (4)	DGG package		64	0000
$\theta_{JA}$	Package thermal impedance <sup>(4)</sup>	DL package		56	°C/W
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) This value is limited to 4.6 V maximum.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

### **RECOMMENDED OPERATING CONDITIONS**<sup>(1)</sup>

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		1.65	3.6	V	
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	$0.65  imes V_{CC}$			
$V_{\text{IH}}$	High-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V	1.7		V	
		$V_{CC}$ = 2.7 V to 3.6 V	2			
		$V_{CC}$ = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		
V <sub>IL</sub>	Low-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V		0.7	V	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8		
VI	Input voltage		0	V <sub>CC</sub>	V	
Vo	Output voltage		0	V <sub>CC</sub>	V	
		V <sub>CC</sub> = 1.65 V		-4		
		$V_{CC} = 2.3 V$		-12	~ ^	
I <sub>OH</sub>	High-level output current	$V_{CC} = 2.7 V$		-12	mA	
		$V_{CC} = 3 V$		-24		
		V <sub>CC</sub> = 1.65 V		4		
		$V_{CC} = 2.3 V$		12	mA	
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 2.7 V		12	ША	
		$V_{CC} = 3 V$		24		
$\Delta t/\Delta v$	Input transition rise or fall rate			10	ns/V	
T <sub>A</sub>	Operating free-air temperature		-40	85	°C	

 All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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#### **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

PA	ARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT	
		I <sub>OH</sub> = -100 μA	1.65 V to 3.6 V	V <sub>CC</sub> - 0.2				
		I <sub>OH</sub> = -4 mA	1.65 V	1.2				
		I <sub>OH</sub> = -6 mA	2.3 V	2				
V <sub>OH</sub>			2.3 V	1.7			V	
		I <sub>OH</sub> = -12 mA	2.7 V	2.2				
			3 V	2.4				
		I <sub>OH</sub> = -24 mA	3 V	2				
-		I <sub>OL</sub> = 100 μA	1.65 V to 3.6 V			0.2		
		I <sub>OL</sub> = 4 mA	1.65 V			0.45		
		I <sub>OL</sub> = 6 mA	2.3 V			0.4	V	
V <sub>OL</sub>		1 12 1	2.3 V			0.7	v	
		I <sub>OL</sub> = 12 mA	2.7 V			0.4		
		I <sub>OL</sub> = 24 mA	3 V			0.55		
I <sub>I</sub>		$V_{I} = V_{CC} \text{ or } GND$	3.6 V			±5	μA	
-		V <sub>I</sub> = 0.58 V	1.65 V	25				
		V <sub>I</sub> = 1.07 V	1.65 V	-25				
		V <sub>I</sub> = 0.7 V	2.3 V	45				
I(hold)		V <sub>I</sub> = 1.7 V	2.3 V	-45			μA	
		V <sub>I</sub> = 0.8 V	3 V	75				
		V <sub>1</sub> = 2 V	3 V	-75				
		$V_{I} = 0 \text{ to } 3.6 V^{(2)}$	3.6 V			±500		
l <sub>oz</sub> <sup>(3)</sup>		$V_{O} = V_{CC} \text{ or } GND$	3.6 V			±10	μA	
I <sub>CC</sub>		$V_{I} = V_{CC}$ or GND, $I_{O} = 0$	3.6 V			40	μA	
∆l <sub>CC</sub>		One input at V <sub>CC</sub> - 0.6 V, Other inputs at V <sub>CC</sub> or GND	3 V to 3.6 V			750	μA	
Ci	Control inputs	$V_{I} = V_{CC}$ or GND	3.3 V		3		pF	
C <sub>io</sub>	A or B ports	$V_0 = V_{CC}$ or GND	3.3 V		7		pF	

TEXAS

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(1) All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . (2) This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

(3) For I/O ports, the parameter  $I_{\text{OZ}}$  includes the input leakage current.

### TIMING REQUIREMENTS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			V <sub>CC</sub> = 1.8 V		V <sub>CC</sub> = 1.8 V		V <sub>CC</sub> = ± 0.2		V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = ± 0.3		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX			
f <sub>clock</sub>	Clock frequency			(1)		120		125		150	MHz		
t <sub>w</sub>	Pulse duration, CLK high or low		(1)		3.2		3.2		3		ns		
	Setup time	B data before CLK↑	(1)		1.5		1.2		1.1				
t <sub>su</sub>		SEL before CLK↑	(1)		2.7		2.4		2.1		ns		
		CLKENBA before CLK1	(1)		2.7		2.6		2				
	Hold time	B data after CLK1	(1)		1		0.6		1.2				
t <sub>h</sub>		SEL after CLK↑	(1)		0.5		0.2		0.8		ns		
		CLKENBA after CLK <sup>↑</sup>	(1)		0.1		0.1		0.3				

(1) This information was not available at the time of publication.



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### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 1.8 V		V <sub>CC</sub> = ± 0.2	2.5 V 2 V	V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = 2 ± 0.3	3.3 V 3 V	UNIT
	(INFUT)		MIN	ТҮР	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>			(1)		120		125		150		MHz
	А	В		(1)	1	3.9		3.8	1	3.2	
t <sub>pd</sub>	CLK	А		(1)	1	6.1		6.2	1	5.2	ns
t <sub>en</sub>	OEAB or OEBA	A or B		(1)	1	6.1		6.1	1	5.1	ns
t <sub>dis</sub>	OEAB or OEBA	A or B		(1)	1	6.3		5.4	1	4.9	ns

(1) This information was not available at the time of publication.

### **OPERATING CHARACTERISTICS**

 $T_A = 25^{\circ}C$ 

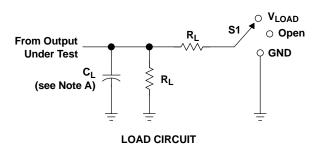
	PARAME	ſER	TEST C	ONDITIONS	V <sub>CC</sub> = 1.8 V TYP	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT
<u> </u>	Power dissipation	Outputs enabled		f 10 MU	(1)	160	160	ρF
C <sub>pd</sub>	capacitance	Outputs disabled	C <sub>L</sub> = 50 pF,	f = 10 MHz	(1)	160	160	pΕ

(1) This information was not available at the time of publication.



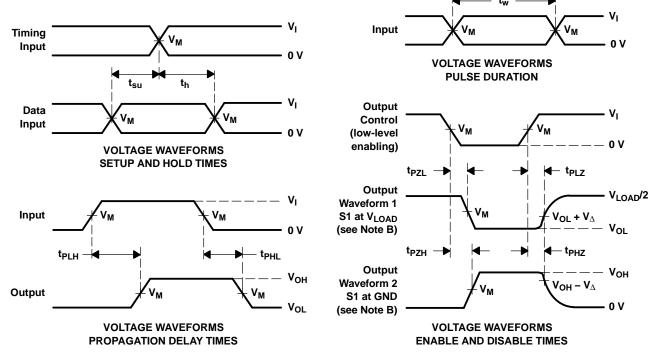


#### PARAMETER MEASUREMENT INFORMATION



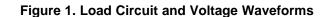
TEST	S1
t <sub>pd</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

V	IN	PUT	V	v	<u>^</u>	Р	V	
V <sub>cc</sub>	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	RL	$V_{\Delta}$	
1.8 V $\pm$ 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	$2 \times V_{CC}$	30 pF	<b>1 k</b> Ω	0.15 V	
2.5 V $\pm$ 0.2 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	$2 \times V_{CC}$	30 pF	<b>500</b> Ω	0.15 V	
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.





10-Dec-2020

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74ALVCH16524DL	ACTIVE	SSOP	DL	56	20	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH16524	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

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<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(<sup>6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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5-Jan-2022

### TUBE



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
SN74ALVCH16524DL	DL	SSOP	56	20	473.7	14.24	5110	7.87

DL (R-PDSO-G56)

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
  - This drawing is subject to change without notice. В.
  - Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15). C.
  - D. Falls within JEDEC MO-118

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